## 2SK2593J

## Silicon N-channel junction FET

For low-frequency amplification For switching circuits

#### ■ Features

- Low noise figure NF
- ullet High gate-drain voltage (source open)  $V_{GDO}$
- SSMini type package, allowing downsizing of the equipment and automatic insertion through the tape packing.

### ■ Absolute Maximum Ratings $T_a = 25^{\circ}C$

Parameter	Symbol	Rating	Unit	
Drain-sourse voltage	$V_{DS}$	55	V	
Gate-drain voltage (Source open)	$V_{GDO}$	-55	V	
Gate-source voltage (Drain open)	$V_{GSO}$	-55	V	
Drain current	$I_{\mathrm{D}}$	30	mA	
Gate current	$I_G$	10	mA	
Power dissipation	$P_{\mathrm{D}}$	125	mW	
Channel temperature	T <sub>ch</sub>	125	°C	
Storage temperature	T <sub>stg</sub>	-55 to +125	°C	

#### Package

- Code SSMini3-F1
- Pin Name
  - 1: Source
  - 2: Drain
- 3: Gate
- Marking Symbol: 2B

## ■ Electrical Characteristics $T_a = 25$ °C $\pm 3$ °C

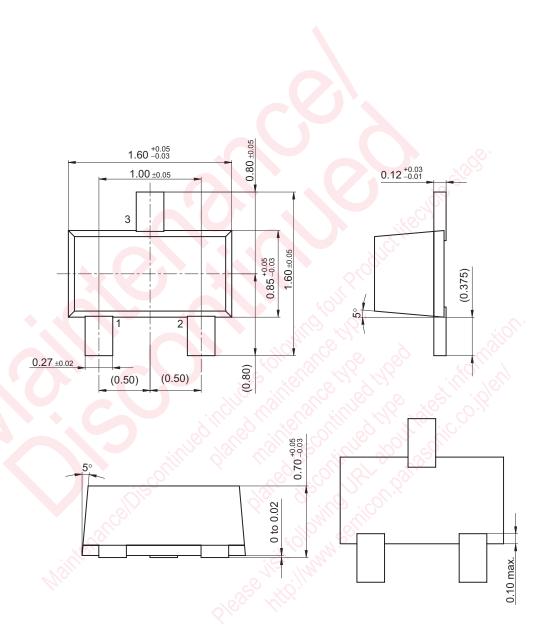
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Gate-drain surrender voltage	V <sub>GDS</sub>	$I_G = -100 \mu\text{A},  V_{DS} = 0$	-55	0),		V
Drain-source current *	$I_{DSS}$	$V_{DS} = 10 \text{ V}, V_{GS} = 0$	1.0	0.9	6.5	mA
Gate-source cutoff current	$I_{GSS}$	$V_{GS} = -30 \text{ V}, V_{DS} = 0$	~ 50°		-10	nA
Gate-source cutoff voltage	V <sub>GSC</sub>	$V_{DS} = 10 \text{ V}, I_{D} = 10 \mu\text{A}$			-5	V
Forward transfer admittance	Y <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_D = 5 \text{ mA}, f = 1 \text{ kHz}$	2.5	7.5		mS
Short-circuit forward transfer capacitance (Common source)	C <sub>iss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$		6.5		pF
Reverse transfer capacitance (Common source)	C <sub>rss</sub>	26 112 1/M		1.9		pF
Noise figure	NF	$V_{DS} = 10 \text{ V}, V_{GS} = 0, f = 100 \text{ Hz}$ $R_g = 100 \text{ k}\Omega$		2.5		dB

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

#### 2. \*: Rank classification

Rank	Р	Q
I <sub>DSS</sub> (mA)	1.0 to 3.0	2.0 to 6.5

SSMini3-F1 Unit: mm



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